



Contribution ID: 107

Type: **Invited**

New and Improved AMS Facilities

Wednesday, June 10, 2009 10:00 AM (30 minutes)

Primary author: SYNAL, Hans-Arno (Laboratory of Ion Beam Physics, ETH Zurich, Switzerland)

Presenter: SYNAL, Hans-Arno (Laboratory of Ion Beam Physics, ETH Zurich, Switzerland)

Session Classification: APPLICATIONS AND ANCILLARY SYSTEMS

Track Classification: Applications